



ISO7220A, ISO7220B, ISO7220C, ISO7220M

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ISO7221A, ISO7221B, ISO7221C, ISO7221M SLLS755K – JULY 2006 – REVISED JANUARY 2010

DUAL DIGITAL ISOLATORS

Check for Samples: ISO7220A, ISO7220B, ISO7220C, ISO7220M, ISO7221A, ISO7221B, ISO7221C, ISO7221M

FEATURES

- 1, 5, 25, and 150-Mbps Signaling Rate Options
 - Low Channel-to-Channel Output Skew; 1 ns max
 - Low Pulse-Width Distortion (PWD);
 1 ns max
 - Low Jitter Content; 1 ns Typ at 150 Mbps
- Typical 25-Year Life at Rated Voltage (see app. note SLLA197 and Figure 20)
- 4000-V_{peak} Isolation, 560 V_{peak} V_{IORM}
 - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2), IEC 61010-1, IEC 60950-1 and CSA Approved
 - 50 kV/µs Typical Transient Immunity

- Operates with 3.3-V or 5-V Supplies
- 4 kV ESD Protection
- High Electromagnetic Immunity
- -40°C to 125°C Operating Range

APPLICATIONS

- Industrial Fieldbus
 - Modbus
 - Profibus™
 - DeviceNet[™] Data Buses
- Computer Peripheral Interface
- Servo Control Interface
- Data Acquisition

DESCRIPTION

The ISO7220 and ISO7221 are dual-channel digital isolators. To facilitate PCB layout, the channels are oriented in the same direction in the ISO7220 and in opposite directions in the ISO7221. These devices have a logic input and output buffer separated by TI's silicon-dioxide (SiO_2) isolation barrier, providing galvanic isolation of up to 4000 V. Used in conjunction with isolated power supplies, these devices block high voltage, isolate grounds, and prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

A binary input signal is conditioned, translated to a balanced signal, then differentiated by the capacitive isolation barrier. Across the isolation barrier, a differential comparator receives the logic transition information, then sets or resets a flip-flop and the output circuit accordingly. A periodic update pulse is sent across the barrier to ensure the proper dc level of the output. If this dc-refresh pulse is not received every 4 μ s, the input is assumed to be unpowered or not being actively driven, and the failsafe circuit drives the output to a logic high state.

The small capacitance and resulting time constant provide fast operation with signaling rates available from 0 Mbps (dc) to 150 Mbps.⁽¹⁾The A-, B- and C-option devices have TTL input thresholds and a noise filter at the input that prevents transient pulses from being passed to the output of the device. The M-option devices have CMOS $V_{CC}/2$ input thresholds and do not have the input noise-filter and the additional propagation delay.

These devices require two supply voltages of 3.3 V, 5 V, or any combination. All inputs are 5-V tolerant when supplied from a 3.3-V supply and all outputs are 4-mA CMOS.

These devices are characterized for operation over the ambient temperature range of -40°C to 125°C.



(1) The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

SINGLE-CHANNEL FUNCTION DIAGRAM



AVAILABLE OPTIONS

PRODUCT	MAX SIGNALING RATE	PACKAGE	INPUT THRESHOLD	CHANNEL DIRECTION	MARKED AS	ORDERING NUMBER
ISO7220A	1 Mbps	SOIC-8	X 1.5 V (TTL)		17220A	ISO7220AD (rail)
1307220A	T Mbps	3010-6	(CMOS compatible)		17220A	ISO7220ADR (reel)
ISO7220B	E Mbpo	SOIC-8	X 1.5 V (TTL)		17220B	ISO7220BD (rail)
13072208	5 Mbps	3010-6	(CMOS compatible Same direction		172208	ISO7220BDR (reel)
ISO7220C	25 Mbps	SOIC-8	X 1.5 V (TTL)	Same direction	17220C	ISO7220CD (rail)
13072200	25 Mbps	3010-6	(CMOS compatible)		172200	ISO7220CDR (reel)
ISO7220M	150 Mbps	SOIC-8	V _{CC} /2 (CMOS)		17220M	ISO7220MD (rail)
1307220101		3010-6	V _{CC} /2 (CIVIOS)		17220101	ISO7220MDR (reel)
ISO7221A	1 Mbpo	SOIC-8	X 1.5 V (TTL)		I7221A	ISO7221AD (rail)
1307221A	1 Mbps	3010-6	(CMOS compatible)		172218	ISO7221ADR (reel)
ISO7221B	E Mbpo	SOIC-8	X 1.5 V (TTL)		I7221B	ISO7221BD (rail)
13072218	5 Mbps	3010-6	(CMOS compatible)	Opposite directions	172210	ISO7221ABR (reel)
IS07221C	25 Mbps	SOIC-8	X 1.5 V (TTL)	Opposite directions	17221C	ISO7221CD (rail)
13072210	25 Mbps	3010-8	(CMOS compatible)		1/2210	ISO7221CDR (reel)
ISO7221M	150 Mbps	SOIC-8			I7221M	ISO7221MD (rail)
1307221101	130 Mbps	3010-8	V _{CC} /2 (CMOS)		17 22 1101	ISO7221MDR (reel)

REGULATORY INFORMATION

VDE	CSA	UL
Certified according to IEC 60747-5-2		Recognized under 1577 Component Recognition Program ⁽¹⁾
File Number: 40016131	File Number: 1698195	File Number: E181974

(1) Production tested ≥3000 VRMS for 1 second in accordance with UL 1577.

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ISO7220A, ISO7220B, ISO7220C, ISO7220M ISO7221A, ISO7221B, ISO7221C, ISO7221M

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ABSOLUTE MAXIMUM RATINGS⁽¹⁾

					VALUE	UNIT
V _{CC}	Supply voltage	⁽²⁾ , V _{CC1} , V _{CC2}			–0.5 to 6	V
VI	Voltage at IN, 0	TUC			-0.5 to 6	V
I _O	Output current				±15	mA
	Human Body Model	Electrostatic discharge JEDEC Standard 22, Test Method A114-C.01		±4	kV	
ESD	Electrostatic discharge	Field-Induced-Charged Device Model	JEDEC Standard 22, Test Method C101	All pins	±1	κv
		Machine Model	ANSI/ESDS5.2-1996		±200	V
TJ	Maximum junct	ion temperature			170	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values except differential I/O bus voltages are with respect to network ground terminal and are peak voltage values.

RECOMMENDED OPERATING CONDITIONS

			MIN	TYP	MAX	UNIT
V _{CC}	Supply voltage ⁽¹⁾ , V _{CC1} , V _{CC2}		3		5.5	V
I _{OH}	High-level output current				4	mA
I _{OL}	Low-level output current		-4			mA
		ISO722xA	1	0.67		μs
	Input pulse width ⁽²⁾	ISO722xB	200	100		
t _{ui}	input pulse width ?	ISO722xC	40	33		ns
		ISO722xM	6.67	5		
		ISO722xA	0	1500	1000	kbps
4 /4	Signaling rate (2)	ISO722xB	0	10	5	Mbps
1/t _{ui}	Signaling rate	ISO722xC	0	30	25	
	Signaling rate ⁽²⁾	200	150			
V _{IH}	High-level input voltage	100700-4 100700-0	2		V _{CC}	V
VIL	Low-level input voltage	ISO722xA, ISO722xC	0		0.8	V
VIH	High-level input voltage	100700-14	0.7 V _{CC}		V _{CC}	V
V _{IL}	Low-level input voltage	ISO722xM	0		0.3 V _{CC}	V
TJ	Junction temperature		-40		150	°C
Н	External magnetic field-strength immunity per I certification	IEC 61000-4-8 & IEC 61000-4-9			1000	A/m

(1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.

For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

(2) Typical signaling rate and Input pulse width are measured at ideal conditions at 25°C.

Product Folder Link(s): ISO7220A ISO7220B ISO7220C ISO7220M ISO7221A ISO7221B ISO7221C ISO7221M

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TEXAS INSTRUMENTS

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ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPL	Y CURRENT		1				
	ISO7220x				1	2	
	ISO7221	Quiescent	$V_I = V_{CC}$ or 0 V, no load		8.5	17	
	ISO7220A, ISO7220B	4 Milera			2	3	
I _{CC1}	ISO7221A, ISO7221B	1 Mbps	$V_I = V_{CC}$ or 0 V, no load		10	18	
	ISO7220C, ISO7220M	05 Mba			4	9	
	ISO7221C, ISO7221M	25 Mbps	$V_{I} = V_{CC}$ or 0 V, no load		12	22	
	ISO7220x	0			16	31	mA
	ISO7221x	Quiescent	$V_I = V_{CC}$ or 0 V, no load		8.5	17	
	ISO7220A, ISO7220B	4 Milera	V = V or $0 V$ polloped		17	32	
I _{CC2}	ISO7221A, ISO7221B	1 Mbps	$V_{I} = V_{CC}$ or 0 V, no load		10	18	
	ISO7220C, ISO7220M	25 Mbps			20	34	
	ISO7221C, ISO7221M		$V_{I} = V_{CC}$ or 0 V, no load		12	22	
			I _{OH} = -4 mA, See Figure 1	V _{CC} – 0.8	4.6		
V _{OH}	High-level output voltage		$I_{OH} = -20 \ \mu A$, See Figure 1	V _{CC} – 0.1	5		V
	Law beach and a day to all a set		I _{OL} = 4 mA, See Figure 1		0.2	0.4	V
V _{OL}	Low-level output voltage		I _{OL} = 20 μA, See Figure 1		0	0.1	V
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current					10	
IIL	Low-level input current		IN from 0 V to V _{CC}	-10			μA
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_{I} = V_{CC}$ or 0 V, See Figure 3	25	50		kV/μs

(1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{cc1} and V_{cc2} at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{pLH} , t _{pHL}	Propagation delay	ISO722xA		280	405	475	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	14	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xB		42	55	70	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$		– See Figure 1		1 22 32	3	ns
t _{pLH} , t _{pHL}	Propagation delay			22		42	115
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	2	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xM		6	10	16	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				0.5	1	
		ISO722xA				180	
	\mathbf{D} at the most element (2)	ISO722xB				17	
t _{sk(pp)}	_{sk(pp)} Part-to-part skew ⁽²⁾	ISO722xC				10	ns
		ISO722xM				3	

(1) Also referred to as pulse skew.

(2) t_{sk(pp)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

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Product Folder Link(s): ISO7220A ISO7220B ISO7220C ISO7220M ISO7221A ISO7221B ISO7221C ISO7221M



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SWITCHING CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V OPERATION (continued)

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		ISO722xA			3	15	ns
t _{sk(o)}	Channel-to-channel output skew ⁽³⁾	ISO722xB			0.6	3	
		ISO722xC/M			0.2	1	
t _r	Output signal rise time				1		
t _f	Output signal fall time		See Figure 1	1			ns
t _{fs}	Failsafe output delay time from input power loss		See Figure 2		3		μS
t _{jit(pp)}	Peak-to-peak eye-pattern jitter	ISO722xM	150 Mbps PRBS NRZ data, 5-bit max same polarity input, both channels, See Figure 4, Figure 17	1			ns
)u(bb)			150 Mbps unrestricted bit run length data input, both channels, See Figure 4		2		

(3) $t_{sk(0)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} at 5 V, V_{CC2} at 3.3 V⁽¹⁾ OPERATION

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT						
	ISO7220x	Ouissant			1	2	
	ISO7221x	Quiescent	$V_{I} = V_{CC}$ or 0 V, no load		8.5	17	
	ISO7220A, ISO7220B	4.54			2	3	
I _{CC1}	ISO7221A, ISO7221B	1 Mbps	$V_I = V_{CC}$ or 0 V, no load		10	18	
	ISO7220C, ISO7220M	05.14			4	9	
	ISO7221C, ISO7221M	25 Mbps	$V_I = V_{CC}$ or 0 V, no load		12	22	
	ISO7220x				8	18	mA
	ISO7221x	Quiescent	$V_I = V_{CC}$ or 0 V, no load		4.3	9.5	
	ISO7220A, ISO7220B	4.54			9	19	
I _{CC2}	ISO7221A, ISO7221B	1 Mbps	$V_I = V_{CC}$ or 0 V, no load		5	11	
	ISO7220C, ISO7220M	05.14	<u>х</u> х ах н н		10	20	
	ISO7221C, ISO7221M	25 Mbps	$V_{I} = V_{CC}$ or 0 V, no load		6	12	
		ISO7220x	I _{OH} = -4 mA, See Figure 1	$V_{CC} - 0.4$			V
V _{OH}	High-level output voltage	ISO7221x (5-V side)		$V_{CC} - 0.8$			
			$I_{OH} = -20 \ \mu A$, See Figure 1	$V_{CC} - 0.1$			
V			I _{OL} = 4 mA, See Figure 1			0.4	V
V _{OL}	Low-level output voltage		$I_{OL} = 20 \ \mu A$, See Figure 1			0.1	v
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current					10	•
IIL	Low-level input current		IN from 0 V to V _{CC}	-10			μA
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_{I} = V_{CC}$ or 0 V, See Figure 3	15	40		kV/μs

over recommended operating conditions (unless otherwise noted)

(1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

Product Folder Link(s): IS07220A IS07220B IS07220C IS07220M IS07221A IS07221B IS07221C IS07221M

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SWITCHING CHARACTERISTICS: V_{CC1} at 5 V, V_{CC2} at 3.3 V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{pLH} , t _{pHL}	Propagation delay	ISO722xA		285	410	480	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	14	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xB		45	58	75	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$		See Figure 1		1	3	ns
t _{pLH} , t _{pHL}	Propagation delay	ISO722xC	See rigure i	25	36	48	115
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	2	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xM		7	12	20	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				0.5	1	
		ISO722xA				180	
	(pp) Part-to-part skew ⁽²⁾	ISO722xB				17	
t _{sk(pp)}	Fait-to-pait skew the	ISO722xC				10	
		ISO722xM				5	ns
		ISO722xA			3	15	
t _{sk(o)}	Channel-to-channel output skew (3)	ISO722xB			0.6	3	
		ISO722xC/M			0.2	1	
t _r	Output signal rise time				2		
t _f	Output signal fall time		See Figure 1		2		ns
t _{fs}	Failsafe output delay time from input power loss		See Figure 2		3		μs
t _{jit(pp)}	Peak-to-peak eye-pattern jitter	ISO722xM	150 Mbps PRBS NRZ data, 5-bit max same polarity input, both channels, See Figure 4, Figure 17		1		ns
, ч <i>Е</i> /			150 Mbps unrestricted bit run length data input, both channels, See Figure 4		2	IIS	

(1) Also referred to as pulse skew.

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tsk(pp) is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices (2)

 $t_{sk(p)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads. (3)



ISO7220A, ISO7220B, ISO7220C, ISO7220M ISO7221A, ISO7221B, ISO7221C, ISO7221M

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ELECTRICAL CHARACTERISTICS: V_{CC1} at 3.3 V, V_{CC2} at 5 V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT		1	F			
	ISO7220x	Ordenset			0.6	1	
	ISO7221x	Quiescent	$V_{I} = V_{CC}$ or 0 V, no load		4.3	9.5	
	ISO7220A, ISO7220B	4 14-22			1	2	
I _{CC1}	ISO7221A, ISO7221B	1 Mbps	$V_{I} = V_{CC}$ or 0 V, no load		5	11	
	ISO7220C, ISO7220M	OF Mhaa			2	4	
	ISO7221C, ISO7221M	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ no load}$		6	12	
	ISO7220x	Ordenset	$V_1 = V_{CC}$ or 0 V, no load		16	31	mA
	ISO7221x	Quiescent			8.5	17	
	ISO7220A, ISO7220B	4 14-22			18	32	
I _{CC2}	ISO7221A, ISO7221B	1 Mbps	$V_{I} = V_{CC}$ or 0 V, no load		10	18	
	ISO7220C, ISO7220M	OF Mhaa	$V_1 = V_{CC}$ or 0 V, no load		20	34	
	ISO7221C, ISO7221M	25 Mbps			12	22	
		ISO7220x		V _{CC} - 0.8			
V _{OH}	High-level output voltage	ISO7221x (3.3-V side)	I _{OH} = -4 mA, See Figure 1	$V_{CC} - 0.4$			
			$I_{OH} = -20 \ \mu A$, See Figure 1	V _{CC} – 0.1			V
V			IOL = 4 mA, See Figure 1			0.4	
V _{OL}	Low-level output voltage		IOL = 20 μA, See Figure 1		0	0.1	
V _{I(HYS)}	Input threshold voltage hysteresis				150		mV
I _{IH}	High-level input current		IN from 0 V or V _{CC}			10	۸
IIL	Low-level input current			-10			μA
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_I = V_{CC}$ or 0 V, See Figure 3	15	40		kV/μs

(1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

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SWITCHING CHARACTERISTICS: V_{cc1} at 3.3 V, V_{cc2} at 5 V OPERTAION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{pLH} , t _{pHL}	Propagation delay	ISO722xA		285	395	480	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	18	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xB		45	58	75	
PWD	Pulse-width distortion $\left t_{pHL} - t_{pLH}\right ^{(1)}$		- See Figure 1		1	4	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xC		25	36	48	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	3	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xM		7	12	21	
PWD	Pulse-width distortion $\left t_{\text{pHL}} - t_{\text{pLH}}\right ^{(1)}$				0.5	1	ns
		ISO722xA				190	
+	Part-to-part skew (2)	ISO722xB				17	
t _{sk(pp)}	Fait-to-pait skew to	ISO722xC				10	
		ISO722xM				5	
		ISO722xA			3	15	
t _{sk(o)}	Channel-to-channel output skew ⁽³⁾	ISO722xB			0.6	3	
		ISO7220C/M			0.2	1	
t _r	Output signal rise time		- See Figure 1		1		
t _f	Output signal fall time				1		1
t _{fs}	Failsafe output delay time from input po	wer loss	See Figure 2		3		μS
t _{jit(pp)}	Peak-to-peak eye-pattern jitter	ISO722xM	150 Mbps PRBS NRZ data, 5-bit max same polarity input, both channels, See Figure 4, Figure 17		1		ns
, w F/	· · · ·		150 Mbps unrestricted bit run length data input, both channels, See Figure 4		2		

(1) Also referred to as pulse skew.

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(2)

 $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits. $t_{sk(0)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads. (3)



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ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 3.3 $V^{(1)}$ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT		<u>"</u>	L		1	
	ISO7220x	Quiesent			0.6	1	
	ISO7221x	Quiescent	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ no load}$		4.3	9.5	
	ISO7220A, ISO7220B	4. Milana			1	2	
I _{CC1}	ISO7221A, ISO7221B	1 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ no load}$		5	11	
	ISO7220C, ISO7220M	05 Miles			2	4	
	ISO7221C, ISO7221M	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ no load}$		6	12	
	ISO7220x	Q ·			8	18	mA
	ISO7221x	Quiescent	$V_I = V_{CC}$ or 0 V, no load		4.3	9.5	
1	ISO7220A, ISO7220B	4.84			9	19	
I _{CC2}	ISO7221A, ISO7221B	1 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ no load}$		5	11	
	ISO7220C, ISO7220M	05 Miles			10	20	
	ISO7221C, ISO7221M	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ no load}$		6	12	
v			I _{OH} = -4 mA, See Figure 1	$V_{CC} - 0.4$	3		
V _{OH}	High-level output voltage		$I_{OH} = -20 \ \mu A$, See Figure 1	V _{CC} - 0.1	3.3		V
V			I _{OL} = 4 mA, See Figure 1		0.2	0.4	v
V _{OL}	Low-level output voltage		I_{OL} = 20 μ A, See Figure 1		0	0.1	
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current		IN from 0 V or V			10	
IIL	Low-level input current		IN from 0 V or V _{CC}	-10			μA
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_{I} = V_{CC}$ or 0 V, See Figure 3	15	40		kV/μs

(1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

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SWITCHING CHARACTERISTICS

V_{CC1} and V_{CC2} at 3.3 V operation, over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{pLH} , t _{pHL}	Propagation delay	ISO722xA		290	400	485	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	18	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xB		46	62	78	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$		- See Figure 1		1	4	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xC	See Figure 1	26	40	52	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				1	3	
t _{pLH} , t _{pHL}	Propagation delay	ISO722xM		8	16	25	
PWD	Pulse-width distortion $ t_{pHL} - t_{pLH} ^{(1)}$				0.5	1	ns
	Part-to-part skew ⁽²⁾	ISO722xA				190	
•		ISO722xB				17	
t _{sk(pp)}		ISO722xC				10	
		ISO722xM				5	
		ISO722xA			3	15	
t _{sk(o)}	Channel-to-channel output skew ⁽³⁾	ISO722xB			0.6	3	
		ISO722xC/M			0.2	1	
t _r	Output signal rise time				2		
t _f	Output signal fall time		See Figure 1		2		
t _{fs}	Failsafe output delay time from input power los	s	See Figure 2		3		μs
t _{jit(pp)}	Peak-to-peak eye-pattern jitter	ISO722xM	150 Mbps PRBS NRZ data, 5-bit max same polarity input, both channels, See Figure 4, Figure 17		1		ns
, u F/	······································		150 Mbps unrestricted bit run length data input, both channels, See Figure 4		2		

(1) Also referred to as pulse skew.

(2)

 $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits. $t_{sk(0)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads. (3)

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PARAMETER MEASUREMENT INFORMATION



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, t_r \leq 3 ns, t_f \leq 3 ns, Z₀ = 50 Ω .
- B. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



A. C_L = 15 pF and includes instrumentation and fixture capacitance within ±20%.





A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.





NOTE: PRBS bit pattern run length is $2^{16} - 1$. Transition time is 800 ps.



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Product Folder Link(s): ISO7220A ISO7220B ISO7220C ISO7220M ISO7221A ISO7221B ISO7221C ISO7221M

DEVICE INFORMATION

IEC PACKAGE CHARACTERISTICS

	PARAMETER	TEST CONDITIONS			TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal-to-terminal distance through air		4.8			mm
L(I02)	Minimum external tracking (Creepage)	Shortest terminal-to-terminal distance across the package surface	SOIC-8	4.3			mm
CTI	Tracking resistance (Comparative Tracking Index)	DIN IEC 60112 / VDE 0303 Part 1		≥175			V
	Minimum Internal Gap (Internal Clearance)	Distance through the insulation		0.008			mm
R _{IO}	Isolation resistance	Input to output, $V_{IO} = 500$ V, all pins on each side barrier tied together creating a two-terminal device $T_A < 100^{\circ}C$			>10 ¹²		Ω
		Input to output, $V_{IO} = 500 \text{ V}$, $100^{\circ}\text{C} \le \text{T}_{A} \le \text{max}$			>10 ¹¹		Ω
C _{IO}	Barrier capacitance Input to output	V _I = 0.4 sin (4E6πt)			1		pF
CI	Input capacitance to ground	V _I = 0.4 sin (4E6πt)			1		pF

NOTE: Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board do not reduce this distance.

Creepage and clearance on a printed circuit board become equal according to the measurement techniques shown in the *Isolation Glossary*. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

IEC 60664-1 RATINGS TABLE

PARAMETER	TEST CONDITIONS	SPECIFICATION
Basic isolation group	Material group	Illa
	Rated mains voltage ≤150 VRMS	I-IV
Installation classification	Rated mains voltage ≤300 VRMS	1-111
	Rated mains voltage ≤400 VRMS	I-II

IEC 60747-5-2 INSULATION CHARACTERISTICS⁽¹⁾

	PARAMETER	TER TEST CONDITIONS			
V _{IORM}	Maximum working insulation voltage		560		
V _{PR}	Input to output test voltage	Method b1, $V_{PR} = V_{IORM} \times 1.875$, 100% Production test with t = 1 s, Partial discharge <5 pC	1050	V	
VIOTM	Transient overvoltage	t = 60 s	4000		
R _S	Insulation resistance	$V_{IO} = 500 \text{ V} \text{ at } T_{S}$	>10 ⁹	Ω	
	Pollution degree		2		

(1) Climatic Classification 40/125/21

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DEVICE I/O SCHEMATICS



IEC SAFETY LIMITING VALUES

Safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the IO can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
			$\theta_{JA} = 212^{\circ}C/W, V_I = 5.5 V, T_J = 170^{\circ}C, T_A = 25^{\circ}C$			124	~^
IS	supply current	5010-8	$\theta_{JA} = 212^{\circ}C/W, V_{I} = 3.6 V, T_{J} = 170^{\circ}C, T_{A} = 25^{\circ}C$			190	mA
T_S	Maximum case temperature	SOIC-8				150	°C

The safety-limiting constraint is the absolute maximum junction temperature specified in the absolute maximum ratings table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the Thermal Characteristics table is that of a device installed in the JESD51-3, Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages and is conservative. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.

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SOIC-8 PACKAGE THERMAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
0	Junction-to-air		Low-K Thermal Resistance ⁽¹⁾		212		
θ_{JA}			High-K Thermal Resistance		122		°C/W
θ_{JB}	Junction-to-Board Thermal	Resistance			37		°C/W
θ_{JC}	Junction-to-Case Thermal Resistance				69.1		
PD	Device Power Dissipation	ISO722xM	$V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}, C_L = 15 \text{ pF},$ Input a 150 Mbps 50% duty cycle square wave			390	mW

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface mount packages.



Figure 5. SOIC-8 θ_{JC} THERMAL DERATING CURVE per IEC 60747-5-2

DEVICE FUNCTION TABLE

Table 1. ISO7220x or ISO7221x⁽¹⁾

INPUT SIDE V _{CC}	OUTPUT SIDE V _{CC}	INPUT IN	OUTPUT OUT
		Н	Н
PU	PU	L	L
		Open	Н
PD	PU	Х	Н

 PU = Powered Up(Vcc ≥ 3.0V); PD = Powered Down (Vcc ≤ 2.5V); X = Irrelevant; H = High Level; L = Low Level



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ISO7220A, ISO7220B, ISO7220C, ISO7220M ISO7221A, ISO7221B, ISO7221C, ISO7221M

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APPLICATION INFORMATION

Typical Applications







Figure 19. Typical ISO7221 Application Circuit



Figure 20. Time Dependent Dielectric Breakdown Test Results



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ISOLATION GLOSSARY

Creepage Distance — The shortest path between two conductive input to output leads measured along the surface of the insulation. The shortest distance path is found around the end of the package body.



Clearance — The shortest distance between two conductive input to output leads measured through air (line of sight).



Input-to Output Barrier Capacitance — The total capacitance between all input terminals connected together, and all output terminals connected together.

Input-to Output Barrier Resistance — The total resistance between all input terminals connected together, and all output terminals connected together.

Primary Circuit — An internal circuit directly connected to an external supply mains or other equivalent source which supplies the primary circuit electric power.

Secondary Circuit — A circuit with no direct connection to primary power, and derives its power from a separate isolated source.

Comparative Tracking Index (CTI) — CTI is an index used for electrical insulating materials which is defined as the numerical value of the voltage which causes failure by tracking during standard testing. Tracking is the process that produces a partially conducting path of localized deterioration on or through the surface of an insulating material as a result of the action of electric discharges on or close to an insulation surface -- the higher CTI value of the insulating material, the smaller the minimum creepage distance.

Generally, insulation breakdown occurs either through the material, over its surface, or both. Surface failure may arise from flashover or from the progressive degradation of the insulation surface by small localized sparks. Such sparks are the result of the breaking of a surface film of conducting contaminant on the insulation. The resulting break in the leakage current produces an overvoltage at the site of the discontinuity, and an electric spark is generated. These sparks often cause carbonization on insulation material and lead to a carbon track between points of different potential. This process is known as *tracking*.

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Insulation:

Operational insulation — Insulation needed for the correct operation of the equipment.

Basic insulation — Insulation to provide basic protection against electric shock.

Supplementary insulation — Independent insulation applied in addition to basic insulation in order to ensure protection against electric shock in the event of a failure of the basic insulation.

Double insulation — Insulation comprising both basic and supplementary insulation.

Reinforced insulation — A single insulation system which provides a degree of protection against electric shock equivalent to double insulation.

Pollution Degree:

Pollution Degree 1 — No pollution, or only dry, nonconductive pollution occurs. The pollution has no influence.

Pollution Degree 2 — Normally, only nonconductive pollution occurs. However, a temporary conductivity caused by condensation must be expected.

Pollution Degree 3 — Conductive pollution occurs or dry nonconductive pollution occurs which becomes conductive due to condensation which is to be expected.

Pollution Degree 4 - Continuous conductivity occurs due to conductive dust, rain, or other wet conditions.

Installation Category:

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Overvoltage Category — This section is directed at insulation co-ordination by identifying the transient overvoltages which may occur, and by assigning 4 different levels as indicated in IEC 60664.

- I: Signal Level Special equipment or parts of equipment.
- II: Local Level Portable equipment etc.
- III: Distribution Level Fixed installation
- IV: Primary Supply Level Overhead lines, cable systems

Each category should be subject to smaller transients than the category above.

REVISION HISTORY

Changes from Original (July 2006) to Revision A	Page
Deleted "and CSA Apporved" from the UL 1577 FEATURES bullet	1
Added option A to the AVAILABLE OPTIONS table	
Changes from Revision A (August 2006) to Revision B	Page
Added the ELECTICAL CHARACTERISTICS tables to the data sheet	3
Added the EEEO HOAE OHARAOTENIO TOO tables to the data sheet	
 Added the PARAMETER MEASUREMENT INFORMATION to the data sheet 	
Added the PARAMETER MEASUREMENT INFORMATION to the data sheet	
 Added the PARAMETER MEASUREMENT INFORMATION to the data sheet Added the DEVICE INFORMATION section to the data sheet 	

ISO7220A, ISO7220B, ISO7220C, ISO7220M ISO7221A, ISO7221B, ISO7221C, ISO7221M

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Changes from Revision B (May 2007) to Revision C Page • Added the Signaling rate values to the RECOMMENDED OPERATING CONDITIONS table 3 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 5 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 6 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 6 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 6 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 8 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 10 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 10 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 10 • Added Figure 17 cross reference to the Peak-to-peak eye-pattern jitter of the SWITCHING CHARACTERISTICS table 10 • Added Figure 20 - Time Dependent Dielectric Breakdown Test Results 12 • Added Figure 20 - Time Dependent Dielectric Breakdown Test Results 18

Changes from Revision D (June 2007) to Revision E

Changes from Revision E (July 2007) to Revision F

Changes from Revision F (August 2007) to Revision G

•	Added Part Numbers ISO720B and ISO7221B to the data sheet	. 1
•	Added 5-Mbps Signaling rate to the FEATURES list	. 1
•	Added Part Numbers ISO720B and ISO7221B to the AVAILABLE OPTIONS table	. 2
•	Added Part Numbers ISO720B and ISO7221B to the ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V table	. 4
•	Added Part Numbers ISO720B and ISO7221B to the ELECTRICAL CHARACTERISTICS: V_{CC1} at 5 V, V_{CC2} at 3.3 V table	. 5
•	Added Part Numbers ISO720B and ISO7221B to the ELECTRICAL CHARACTERISTICS: V_{CC1} at 3.3 V, V_{CC2} at 5 V table	. 7
	Added Part Numbers ISO720B and ISO7221B to the ELECTRICAL CHARACTERISTICS: V _{CC1} and V _{CC2} at 3.3 V Added PROPAGATION DELAY vs FREE-AIR TEMPERATURE, ISO722xB, Figure 9	

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Product Folder Link(s): IS07220A IS07220B IS07220C IS07220M IS07221A IS07221B IS07221C IS07221M

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Changes from Revision G (March 2008) to Revision H

٠	Added Note: (1) to the RECOMMENDED OPERATING CONDITIONS table	3
•	Added Note: (2) to the ELECTRICAL CHARACTERISTICS: V _{CC1} and V _{CC2} at 5-V table	4
•	Added Note: (3) to the ELECTRICAL CHARACTERISTICS: V _{CC1} at 5 V, V _{CC2} at 3.3 V table	5
•	Added Note: (4) to the ELECTRICAL CHARACTERISTICS: V _{CC1} at 3.3 V, V _{CC2} at 5 V table	7
٠	Added Note: (5) to the ELECTRICAL CHARACTERISTICS: V _{CC1} and V _{CC2} at 3.3 V	9

Changes from Revision H (May 2008) to Revision I

Added "IEC 61010-1, IEC 60950-1 and CSA Approved" to the UL 1577 FEATURES bullet 1

Changes from Revision I (December 2008) to Revision J

Changes from Revision J (May 2009) to Revision K

- Changed column 2 of the AVAILABLE OPTIONS table From: Signaling Rate To: Max Signaling Rate 2
- Changed the the RECOMMENDED OPERATING CONDITIONS so that Note (2) is associated with all device options in the Input pulse width and Signaling rate
 3
- Changed Note (2) From: Typical signaling rate under ideal conditions at 25°C. To: Typical signaling rate and Input pulse width are measured at ideal conditions at 25°C.
 3



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TEXAS INSTRUMENTS

PACKAGING INFORMATION

Orderable Devi	ce Status ⁽¹⁾	⁾ Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
ISO7220AD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220ADG	4 ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220ADR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220ADRG	4 ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220BD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220BDG	4 ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220BDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220BDRG	4 ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220CDG	4 ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220CDRG	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220MD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220MDG	4 ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220MDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7220MDRG	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221AD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221ADG	4 ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221ADR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221ADRG	4 ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221BD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221BDG	4 ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221BDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221BDRG	4 ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

RUMENTS

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
ISO7221CDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221CDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221MD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221MDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221MDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
ISO7221MDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF ISO7221A, ISO7221C :

Automotive: ISO7221A-Q1, ISO7221C-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7220ADR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7220BDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7220CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7220MDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7221ADR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7221BDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7221CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
ISO7221MDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

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PACKAGE MATERIALS INFORMATION

22-Jan-2010



*All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7220ADR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7220BDR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7220CDR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7220MDR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7221ADR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7221BDR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7221CDR	SOIC	D	8	2500	358.0	335.0	35.0
ISO7221MDR	SOIC	D	8	2500	358.0	335.0	35.0

D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.

Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.

E. Reference JEDEC MS-012 variation AA.



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